#### Application/Control No. Applicant(s)/Patent Under Reexamination 09/827,063 HSU ET AL. Examiner **Art Unit** Page 1 of 1 Cheukfan Lee

2622

# Notice of References Cited

### **U.S. PATENT DOCUMENTS**

*	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,489,457	02-1996	Vent, Debra S.	428/40.9
	В	US-6,575,600	06-2003	Huang et al.	362/297
	С	US-6,563,608	05-2003	Nakahara et al.	358/475
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	7	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

	TOTALIST FAIRT BOOMENTO							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р	-						
	Q							
	R	<u>-</u> "						
	S							
	Т							

### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	x							

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.